

#### **N-Channel MOSFET**

#### **General Description**

The WSD60N10GDN56 is the highest performance trench N-Channel MOSFET with extreme high cell density, which provide excellent  $R_{DS(ON)}$  and gate charge for most of the synchronous buck converter applications.

The WSD60N10GDN56 meet the RoHS and Green Product requirement, 100%  $E_{AS}$  guaranteed with full function reliability approved.

#### **Product Summery**

BV <sub>DSS</sub>	R <sub>DS(ON)</sub>	Ι <sub>D</sub>
100V	8.5mΩ	60A

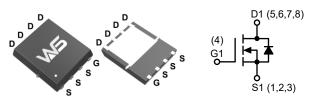
#### Applications

- Power Management in TV Converter.
- DC-DC Converter
- LED TV Back Light

## Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- 100% E<sub>AS</sub> Guaranteed
- Green Device Available

## DFN5X6-8L Pin Configuration



#### Symbol Units **Parameter** Rating **Drain-Source Voltage** 100 V<sub>DS</sub> V ±20 $V_{GS}$ Gate-Source Voltage I<sub>D</sub>@T<sub>C</sub>=25°C 60 **Continuous Drain Current** А Pulsed Drain Current 210 $I_{DP}$ 100 Avalanche Energy, Single pulse mJ $E_{AS}$ P<sub>D</sub>@T<sub>C</sub>=25°C W 125 **Total Power Dissipation** Storage Temperature Range -55 to 150 T<sub>STG</sub> °C $T_{\rm J}$ **Operating Junction Temperature Range** -55 to 150

## **Thermal Data**

Symbol	Parameter	Тур.	Max.	Units
R <sub>θJA</sub>	Thermal Resistance Junction-Ambient <sup>1</sup>		60	°C/W
R <sub>θJC</sub>	Thermal Resistance Junction-Case <sup>1</sup>		1.0	C/W

## Absolute Maximum Ratings



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### Electrical Characteristics (T<sub>J</sub>=25°C, Unless Otherwise Noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =250µA	100			V
D	Statia Drain Source On Desistance	V <sub>GS</sub> =10V , I <sub>D</sub> =10A		8.5	10	
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =4.5V , I <sub>D</sub> =10A		9.5	12	mΩ
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS}=V_{DS}$ , $I_{D}=250\mu A$	1.0		2.5	V
I <sub>DSS</sub>	Drain-Source Leakage Current	$V_{DS}$ =80V, $V_{GS}$ =0V, $T_{J}$ =25°C			1.0	μA
I <sub>GSS</sub>	Gate-Source Leakage Current	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V			±100	nA
Qg	Total Gate Charge (10V)			49.9		
Q <sub>gs</sub>	Gate-Source Charge	$V_{DS}$ =50V , $V_{GS}$ =10V , $I_{D}$ =25A		6.5		nC
Q <sub>gd</sub>	Gate-Drain Charge			12.4		
T <sub>d(on)</sub>	Turn-On Delay Time			20.6		
Tr	Rise Time	V <sub>DD</sub> =50V , V <sub>GS</sub> =10V ,		5		
T <sub>d(off)</sub>	Turn-Off Delay Time	R <sub>G</sub> =2.2Ω , I <sub>D</sub> =25A		51.8		ns
T <sub>f</sub>	Fall Time			9		
C <sub>iss</sub>	Input Capacitance			2604		
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> =50V , V <sub>GS</sub> =0V , f = 1.0MHz		264		pF
C <sub>rss</sub>	Reverse Transfer Capacitance	]		6.5		

#### **Diode Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
ا <sub>S</sub>	Continuous Source Current	$V_{G}=V_{D}=0V$ , Force Current			60	۸
I <sub>SP</sub>	Pulsed Source Current				210	A
V <sub>SD</sub>	Diode Forward Voltage	$V_{GS}$ =0V , $I_{S}$ =12A , $T_{J}$ =25°C			1.3	V
t <sub>rr</sub>	Reverse Recovery Time	- I <sub>F</sub> =12A , dl/dt=100A/µs , T <sub>J</sub> =25°C		60.4		ns
Q <sub>rr</sub>	Reverse Recovery Charge			106.1		nC

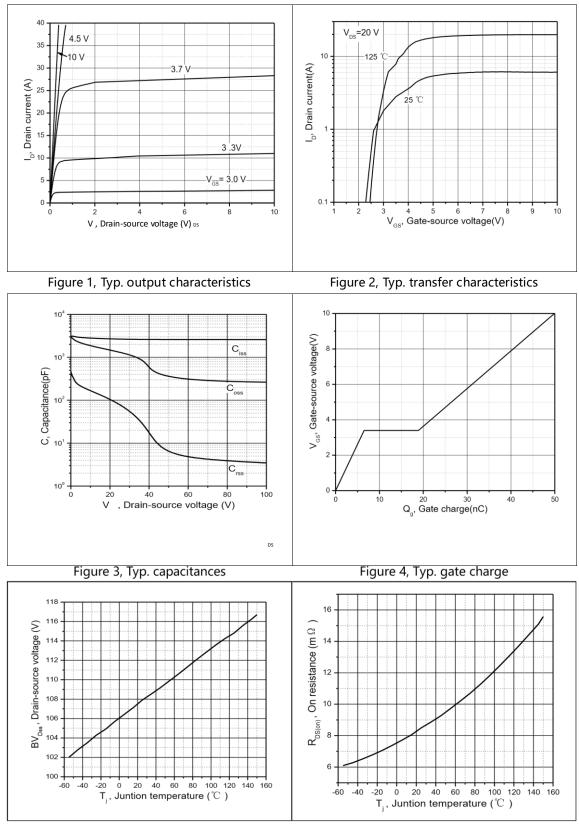
Note:

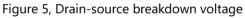
- 1. Calculated continuous current based on maximum allowable junction temperature.
- 2. Repetitive rating: pulse width limited by max. junction temperature.
- 3.  $\ensuremath{\mathsf{P}}_{\ensuremath{\mathsf{D}}}$  is based on max. junction temperature, using junction-case thermal resistance.
- 4. The value of  $R_{BJA}$  is measured with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A$ =25°C.
- 5. V\_{DD}=50V, R\_G=25\Omega, L=0.3mH, starting T\_J=25°C.

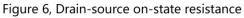


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## **Typical Characteristics**









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## **Typical Characteristics (Cont.)**

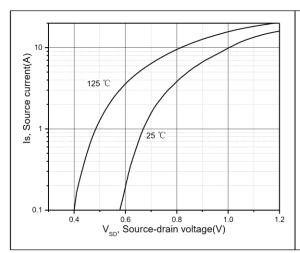


Figure 7, Forward characteristic of body diode

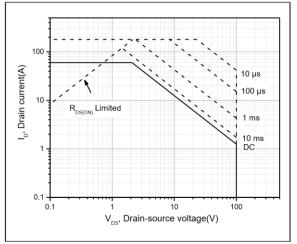
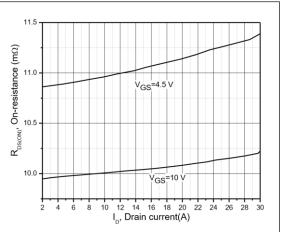
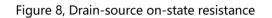


Figure 9, Safe operation area  $T_C=25$  °C

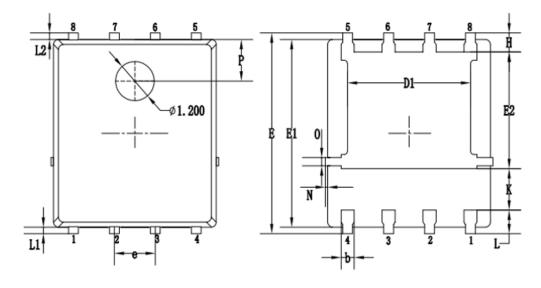


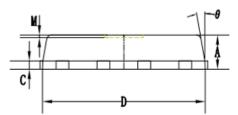




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## **Packaging information**





		MILLIMETERS				
SYMBOLS	MIN.	NOM.	MAX.			
А	0.90	1.05	1.20			
b	0.35	0.40	0.50			
С	0.20	0.25	0.35			
D	4.90	5.05	5.20			
D1	3.72	3.82	3.92			
E	6.00	6.15	6.30			
E1	5.60	5.75	5.90			
E2	3.47	3.57	3.67			
е		1.27 BSC.				
Н	0.48	0.58	0.68			
К	1.17	1.27	1.37			
L	0.64	0.74	0.84			
L1/L2		0.20 REF.				
θ	8°	10°	12°			
М		0.08 REF.				
Ν	0	-	0.15			
0		0.25 REF.				
Р		1.28 REF.				



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